- **Low $r_{DS(on)}$ . . . 1 Ω Typ**
- **Output Short-Circuit Protection**
- **Avalanche Energy . . . 75 mJ**
- **Eight 350-mA DMOS Outputs**
- **50-V Switching Capability**
- **Four Distinct Function Modes**
- **Low Power Consumption**

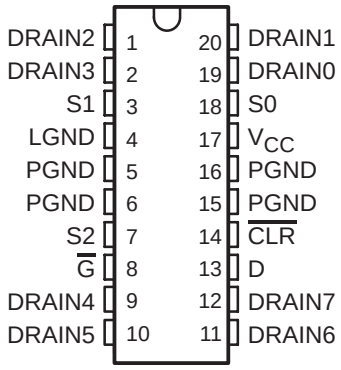
description

This power logic 8-bit addressable latch controls open-drain DMOS-transistor outputs and is designed for general-purpose storage applications in digital systems. Specific uses include working registers, serial-holding registers, and decoders or demultiplexers. This is a multifunctional device capable of operating as eight addressable latches or an 8-line demultiplexer with active-low DMOS outputs. Each open-drain DMOS transistor features an independent chopping current-limiting circuit to prevent damage in the case of a short circuit.

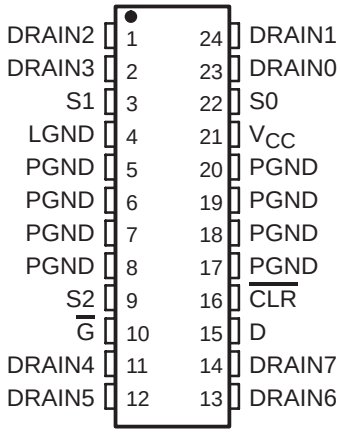
Four distinct modes of operation are selectable by controlling the clear ($\overline{CLR}$) and enable ($\overline{G}$) inputs as enumerated in the function table. In the addressable-latch mode, data at the data-in (D) terminal is written into the addressed latch. The addressed DMOS-transistor output inverts the data input with all unaddressed DMOS-transistor outputs remaining in their previous states. In the memory mode, all DMOS-transistor outputs remain in their previous states and are unaffected by the data or address inputs. To eliminate the possibility of entering erroneous data in the latch, enable $\overline{G}$ should be held high (inactive) while the address lines are changing. In the 8-line demultiplexing mode, the addressed output is inverted with respect to the D input and all other outputs are high. In the clear mode, all outputs are high and unaffected by the address and data inputs.

Separate power ground (PGND) and logic ground (LGND) terminals are provided to facilitate maximum system flexibility. All PGND terminals are internally connected, and each PGND terminal must be externally connected to the power system ground in order to minimize parasitic impedance. A single-point connection between LGND and PGND must be made externally in a manner that reduces crosstalk between the logic and load circuits.

NE PACKAGE
(TOP VIEW)



DW PACKAGE
(TOP VIEW)



FUNCTION TABLE

INPUTS			OUTPUT OF ADDRESSED DRAIN	EACH OTHER DRAIN	FUNCTION
$\overline{CLR}$	$\overline{G}$	D			
H	L	H	L	Q_{io}	Addressable Latch
H	L	L	H	Q_{io}	
H	H	X	Q_{io}	Q_{io}	Memory
L	L	H	L	H	8-Line Demultiplexer
L	L	L	H	H	
L	H	X	H	H	Clear

LATCH SELECTION TABLE

SELECT INPUTS			DRAIN ADDRESSED
S2	S1	S0	
L	L	L	0
L	L	H	1
L	H	L	2
L	H	H	3
H	L	L	4
H	L	H	5
H	H	L	6
H	H	H	7

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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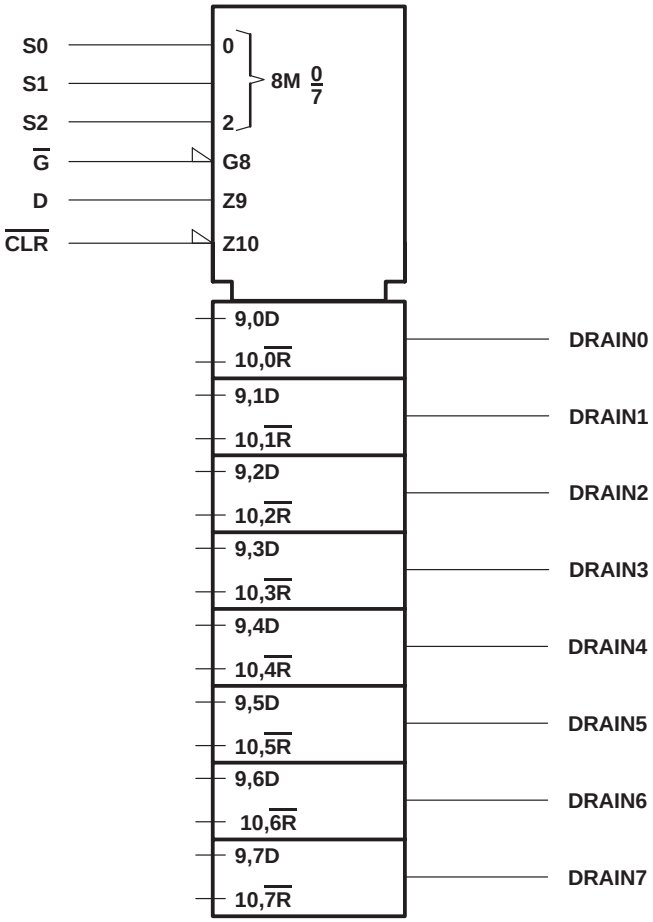
description (continued)

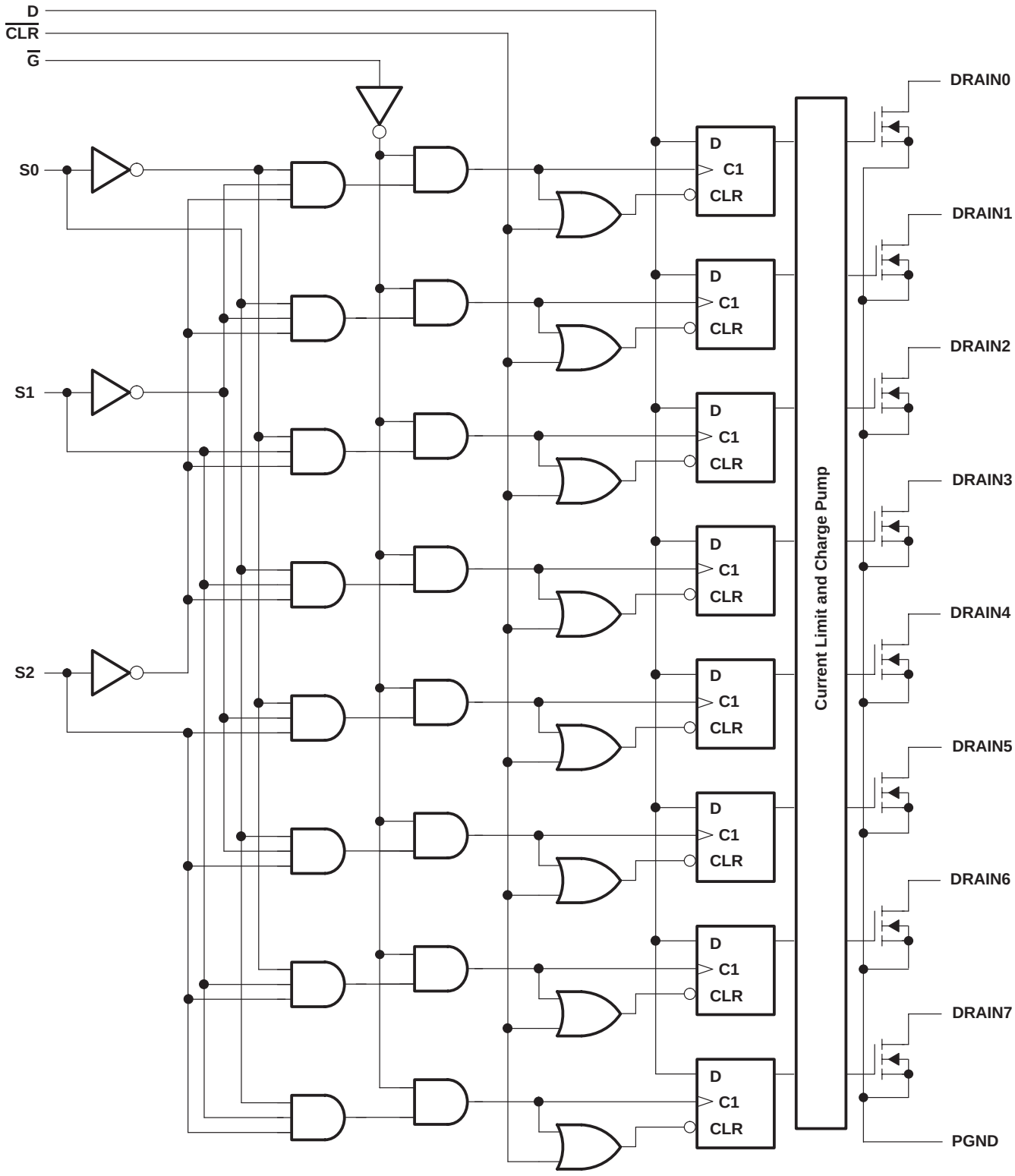
The TPIC6A259 is offered in a thermally-enhanced dual-in-line (NE) package and a wide-body, surface-mount (DW) package. The TPIC6A259 is characterized for operation over the operating case temperature range of −40°C to 125°C.

logic symbol†

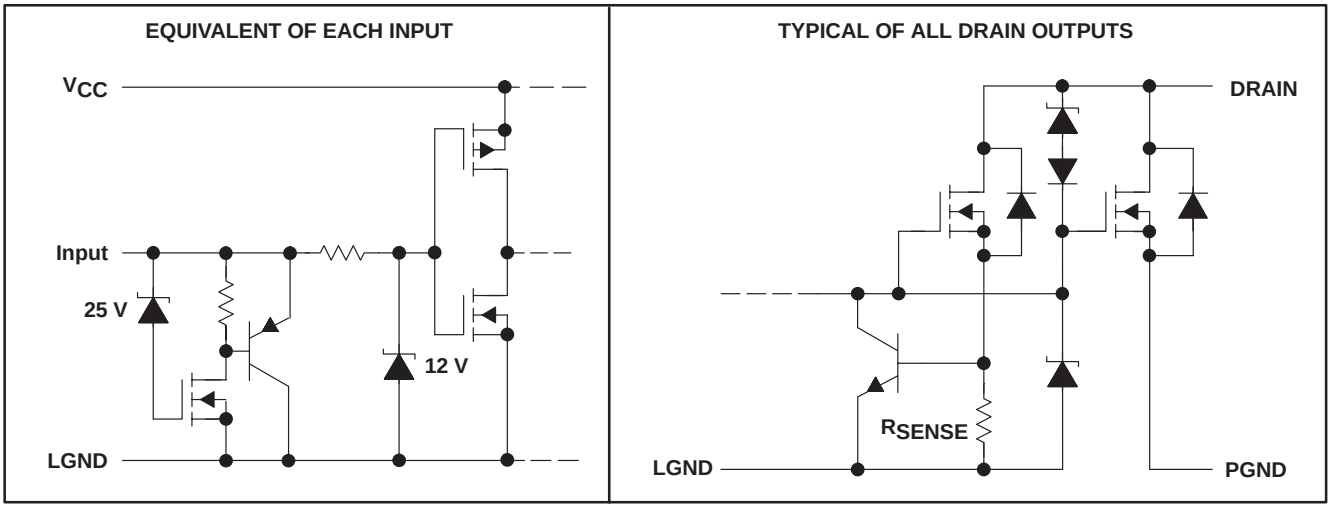


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



schematic of inputs and outputs



absolute maximum ratings over the recommended operating case temperature range (unless otherwise noted)†

Logic supply voltage, V_{CC} (see Note 1)	7 V
Logic input voltage range, V_I	−0.3 V to 7 V
Power DMOS drain-to-source voltage, V_{DS} (see Note 2)	50 V
Continuous source-to-drain diode anode current	1 A
Pulsed source-to-drain diode anode current (see Note 3)	2 A
Pulsed drain current, each output, all outputs on, I_D, T_C = 25°C (see Note 3)	1.1 A
Continuous drain current, each output, all outputs on, I_D, T_C = 25°C	350 mA
Peak drain current single output, T_C = 25°C (see Note 3)	1.1 A
Single-pulse avalanche energy, E_{AS} (see Figure 6)	75 mJ
Avalanche current, I_{AS} (see Note 4)	600 mA
Continuous total dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T_J	−40°C to 150°C
Operating case temperature range, T_C	−40°C to 125°C
Storage temperature range, T_{stg}	−65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to LGND and PGND.
2. Each power DMOS source is internally connected to PGND.
3. Pulse duration ≤ 100 µs, and duty cycle ≤ 2%.
4. DRAIN supply voltage = 15 V, starting junction temperature (T_{JS}) = 25°C, L = 210 mH, and I_{AS} = 600 mA (see Figure 6).

DISSIPATION RATING TABLE

PACKAGE	$T_C \le 25°C$ POWER RATING	DERATING FACTOR ABOVE T_C = 25°C	T_C = 125°C POWER RATING
DW	1750 mW	14 mW/°C	350 mW
NE	2500 mW	20 mW/°C	500 mW

recommended operating conditions

	MIN	MAX	UNIT
Logic supply voltage, V_{CC}	4.5	5.5	V
High-level input voltage, V_{IH}	0.85 V_{CC}	V_{CC}	V
Low-level input voltage, V_{IL}	0	0.15 V_{CC}	V
Pulsed drain output current, T_C = 25°C, V_{CC} = 5 V (see Notes 3 and 5)	−1.8	0.6	A
Setup time, D high before $\overline{G}\uparrow$, t_{su} (see Figure 2)	10		ns
Hold time, D high before $\overline{G}\uparrow$, t_h (see Figure 2)	5		ns
Pulse duration, t_w (see Figure 2)	15		ns
Operating case temperature, T_C	−40	125	°C

electrical characteristics, V_{CC} = 5 V, T_C = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$	Drain-to-source breakdown voltage	I_D = 1 mA			50			V
V_{SD}	Source-to-drain diode forward voltage	I_F = 350 mA,	See Note 3			0.8	1.1	V
I_{IH}	High-level input current	$V_I = V_{CC}$					1	µA
I_{IL}	Low-level input current	V_I = 0					−1	µA
I_{CC}	Logic supply current	I_O = 0,	$V_I = V_{CC}$ or 0			0.5	5	mA
I_{OK}	Output current at which chopping starts	T_C = 25°C,	See Note 5 and Figures 3 and 4		0.6	0.8	1.1	A
$I_{(nom)}$	Nominal current	$V_{DS(on)}$ = 0.5 V, V_{CC} = 5 V,	$I_{(nom)} = I_D$, See Notes 5, 6, and 7	T_C = 85°C,		350		mA
I_D	Off-state drain current	V_{DS} = 40 V,	T_C = 25°C			0.1	1	µA
		V_{DS} = 40 V,	T_C = 125°C			0.2	5	
$r_{DS(on)}$	Static drain-to-source on-state resistance	I_D = 350 mA,	T_C = 25°C	See Notes 5 and 6 and Figures 9 and 10		1	1.5	Ω
		I_D = 350 mA,	T_C = 125°C			1.7	2.5	

switching characteristics, V_{CC} = 5 V, T_C = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PHL}	Propagation delay time, high- to low-level output from D	C_L = 30 pF,	I_D = 350 mA, See Figures 1, 2, and 11		30		ns
t_{PLH}	Propagation delay time, low- to high-level output from D				125		ns
t_r	Rise time, drain output				60		ns
t_f	Fall time, drain output				30		ns
t_a	Reverse-recovery-current rise time	I_F = 350 mA,	di/dt = 20 A/µs, See Notes 5 and 6 and Figure 5		100		ns
t_{rr}	Reverse-recovery time				300		ns

NOTES: 3. Pulse duration ≤ 100 µs and duty cycle ≤ 2%.
5. Technique should limit $T_J - T_C$ to 10°C maximum.
6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.
7. Nominal current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at T_C = 85°C.

thermal resistance

PARAMETER		TEST CONDITIONS		MIN	MAX	UNIT
$R_{\theta JC}$	Thermal resistance, junction-to-case	DW	All eight outputs with equal power		10	°C/W
		NE			10	
$R_{\theta JA}$	Thermal resistance, junction-to-ambient	DW	All eight outputs with equal power		50	°C/W
		NE			50	

PARAMETER MEASUREMENT INFORMATION

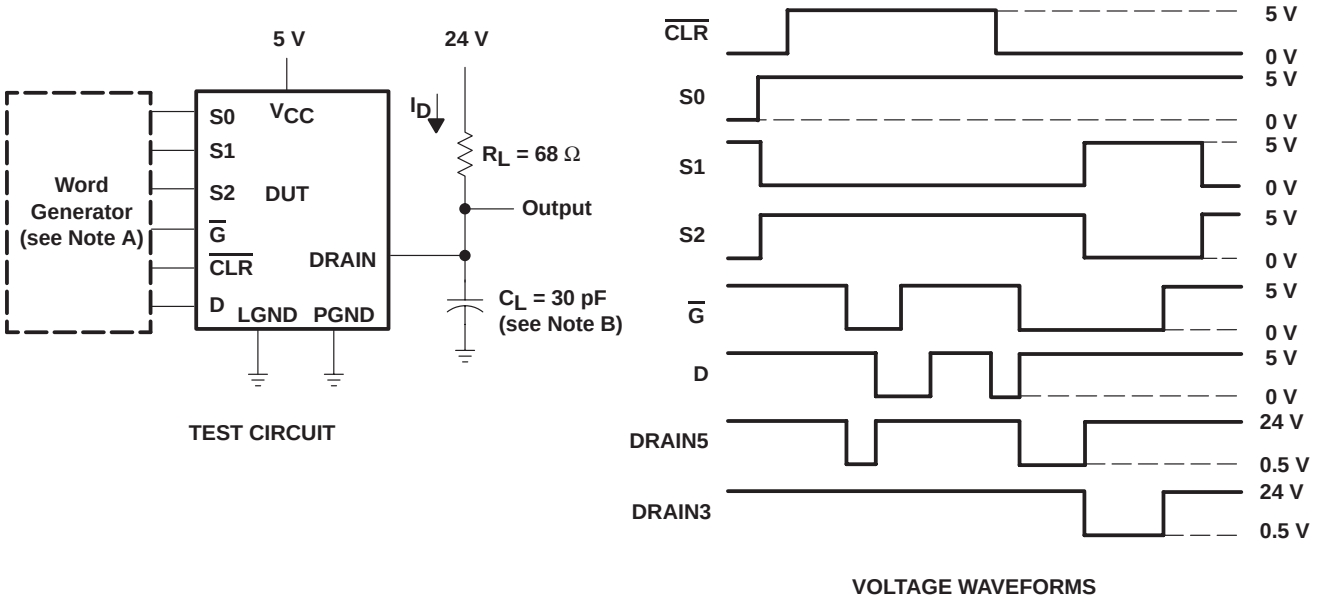


Figure 1. Typical Operation Mode

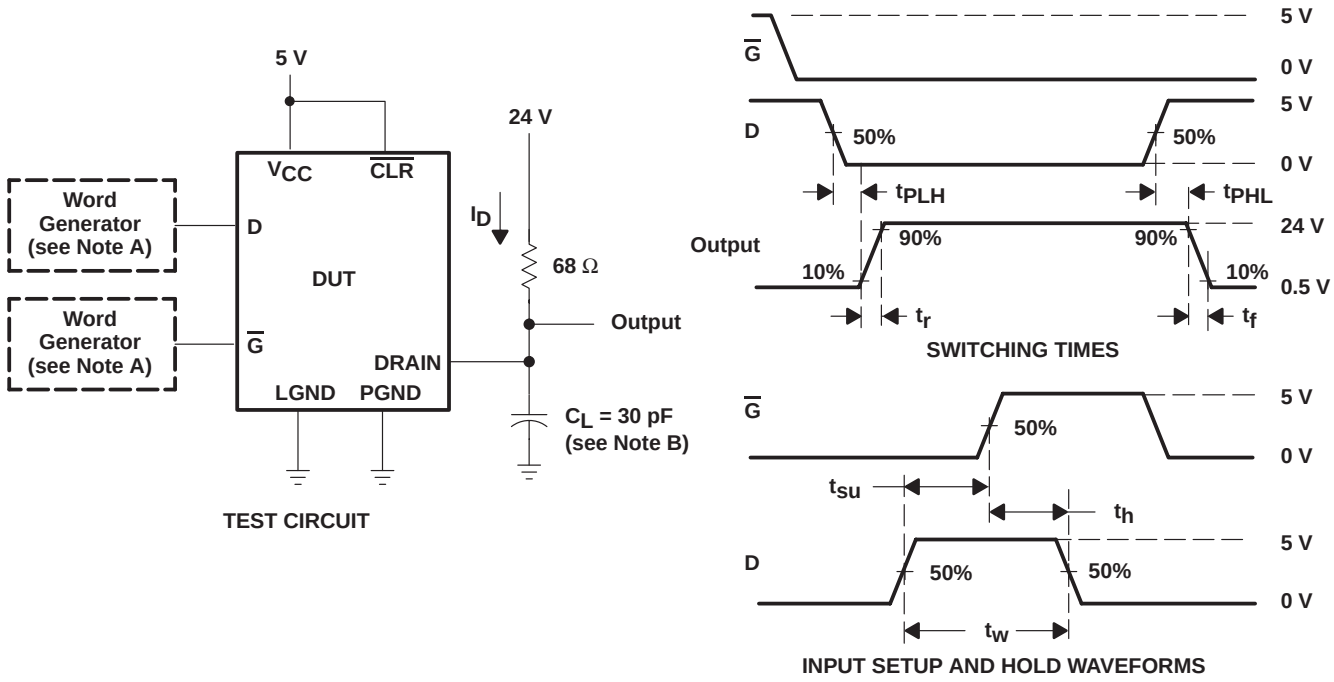


Figure 2. Test Circuit, Switching Times, and Voltage Waveforms

NOTES: A. The word generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, $t_W = 300$ ns, pulsed repetition rate (PRR) = 5 kHz, $Z_O = 50\ \Omega$.
B. C_L includes probe and jig capacitance.

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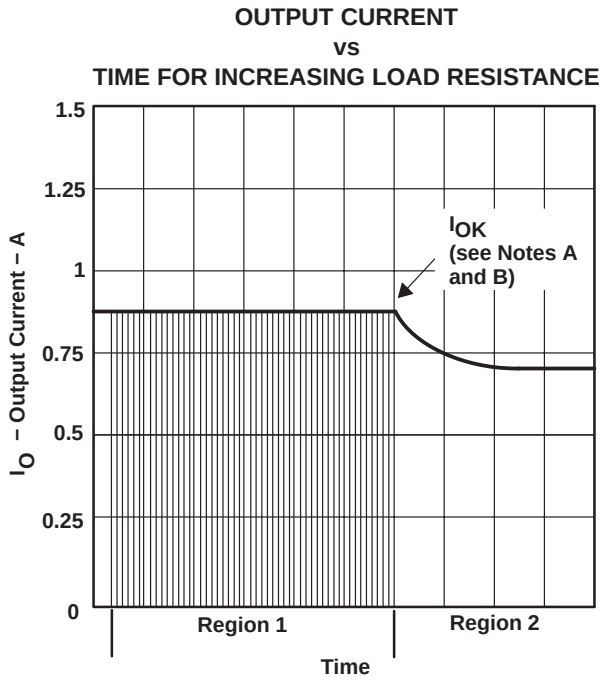
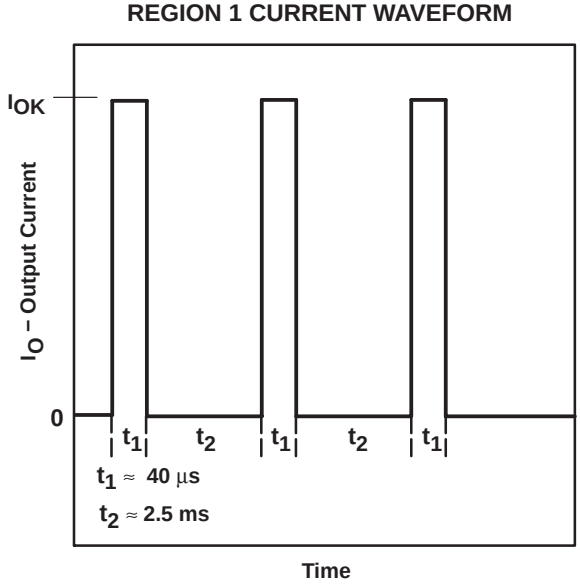
PARAMETER MEASUREMENT INFORMATION





First output current pulses after turn-on in chopping mode with resistive load.

NOTES: A. Figure 3 illustrates the output current characteristics of the device energizing a load having initially low, increasing resistance, e.g., an incandescent lamp. In region 1, chopping occurs and the peak current is limited to I_{OK}. In region 2, output current is continuous. The same characteristics occur in reverse order when the device energizes a load having an initially high, decreasing resistance.

B. Region 1 duty cycle is approximately 2%.

Figure 3. Chopping-Mode Characteristics

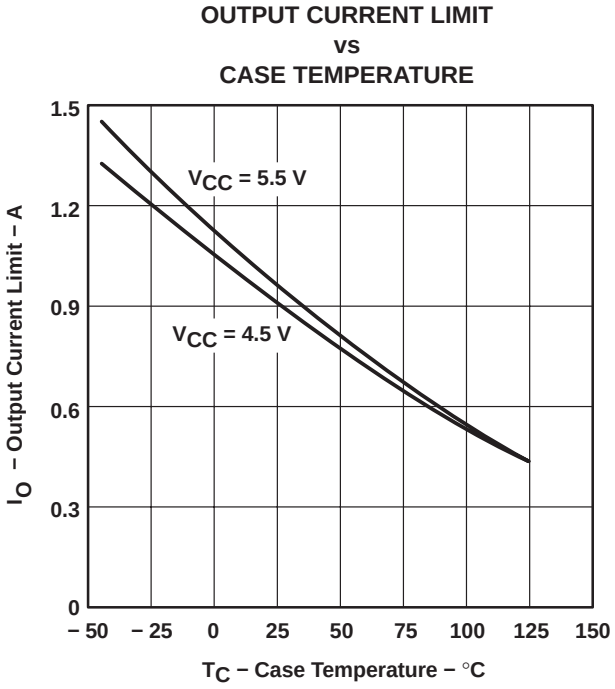
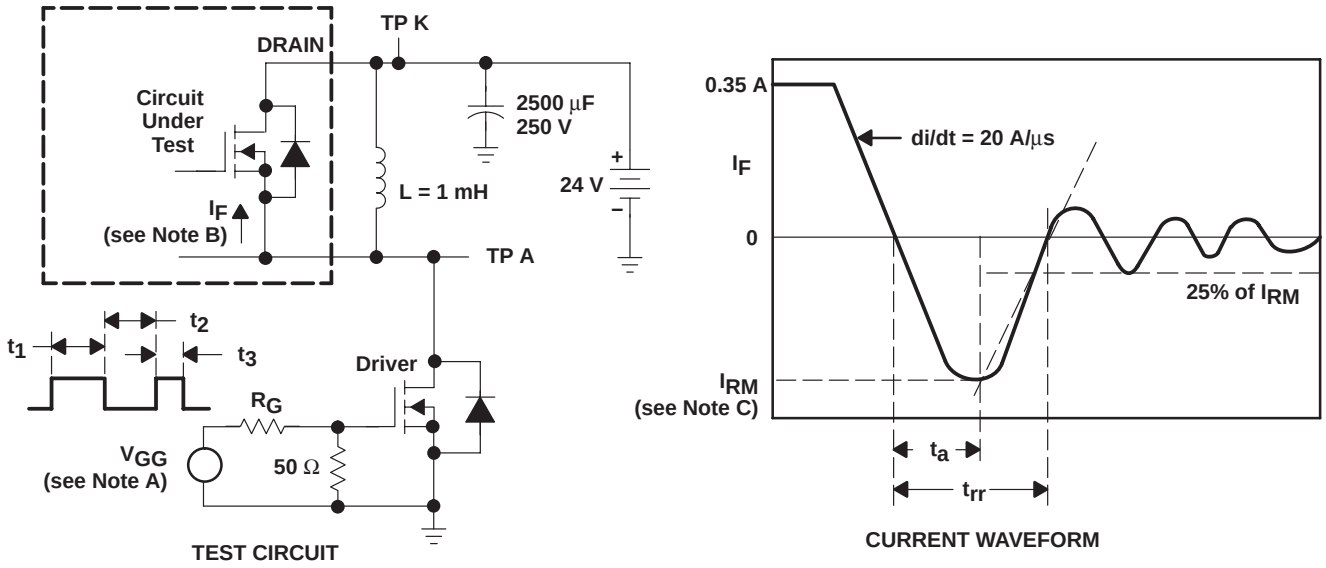


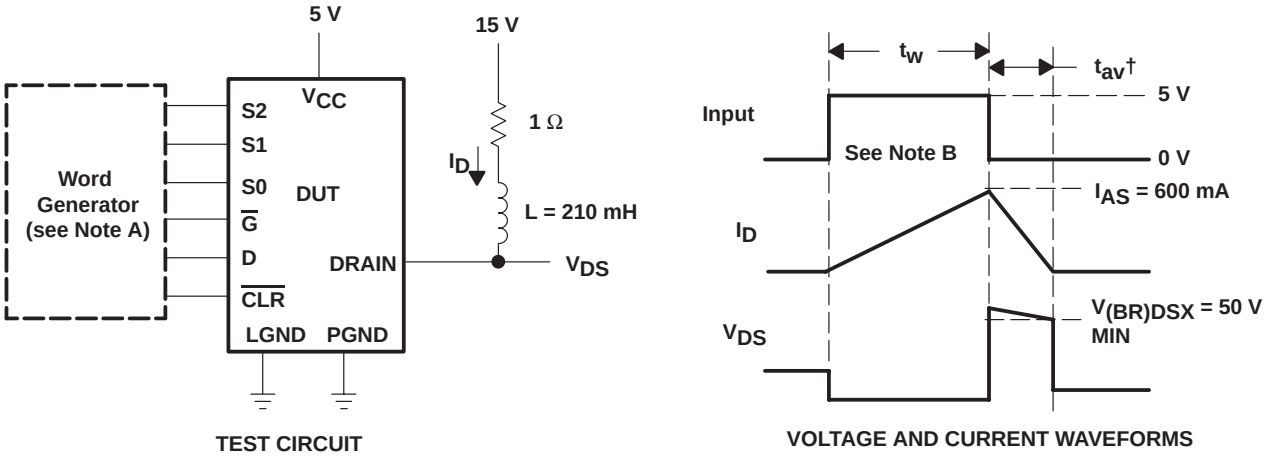
Figure 4

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The V_{GG} amplitude and R_G are adjusted for di/dt = 20 A/μs. A V_{GG} double-pulse train is used to set I_F = 0.35 A, where t_1 = 10 μs, t_2 = 7 μs, and t_3 = 3 μs.
B. The DRAIN terminal under test is connected to the TP K test point. All other terminals are connected together and connected to the TP A test point.
C. I_{RM} = maximum recovery current

Figure 5. Reverse-Recovery-Current Test Circuit and Waveforms of Source-Drain Diode



† Non-JEDEC symbol for avalanche time.

NOTES: A. The word generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, Z_O = 50 Ω.
B. Input pulse duration, t_w, is increased until peak current I_{AS} = 600 mA.
Energy test level is defined as $E_{AS} = (I_{AS} \times V_{(BR)DSX} \times t_{av})/2$ = 75 mJ.

Figure 6. Single-Pulse Avalanche Energy Test Circuit and Waveforms

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TYPICAL CHARACTERISTICS

MAXIMUM CONTINUOUS DRAIN CURRENT OF EACH OUTPUT vs NUMBER OF OUTPUTS CONDUCTING SIMULTANEOUSLY

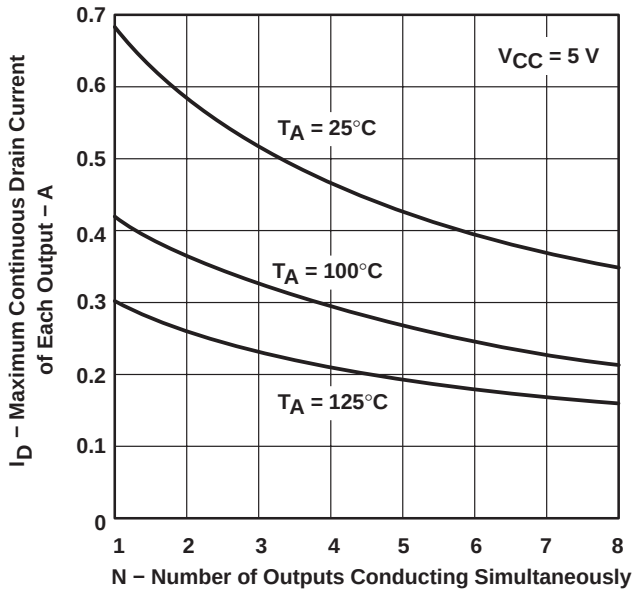


Figure 7

MAXIMUM PEAK DRAIN CURRENT OF EACH OUTPUT vs NUMBER OF OUTPUTS CONDUCTING SIMULTANEOUSLY

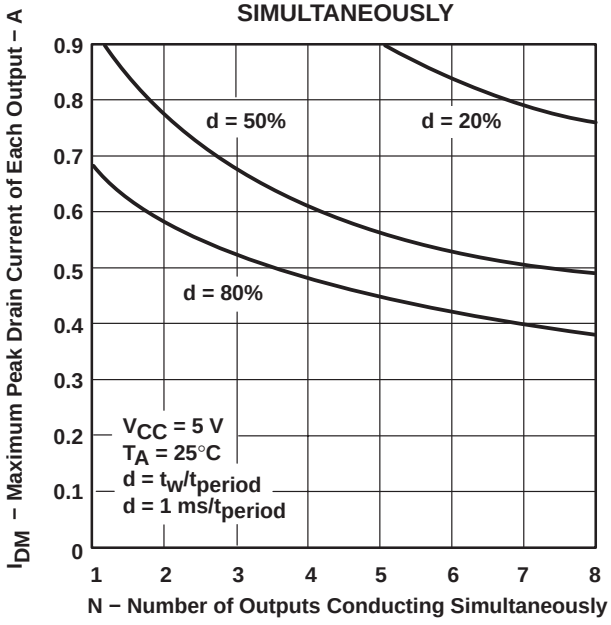


Figure 8

STATIC DRAIN-SOURCE ON-STATE RESISTANCE vs DRAIN CURRENT

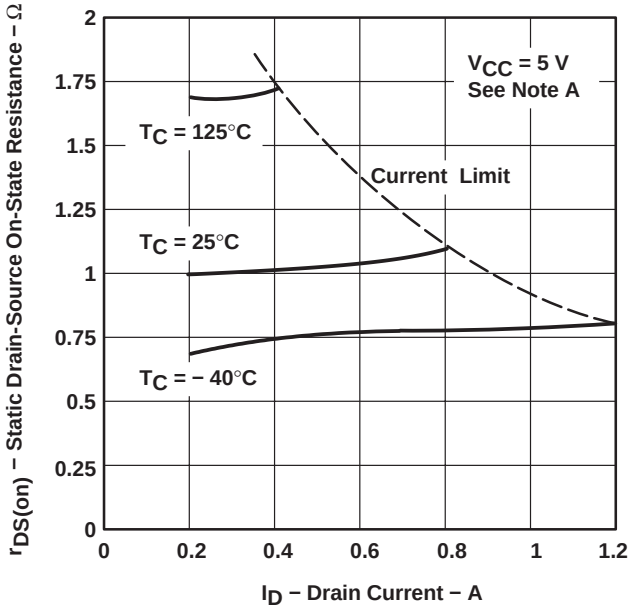


Figure 9

STATIC DRAIN-SOURCE ON-STATE RESISTANCE vs LOGIC SUPPLY VOLTAGE

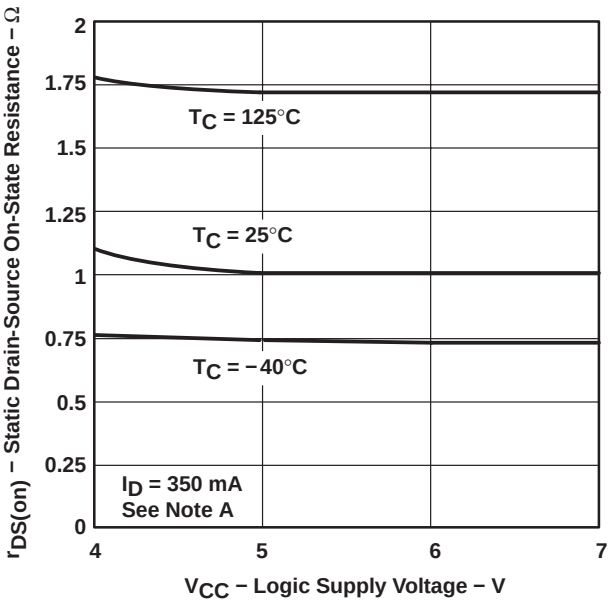
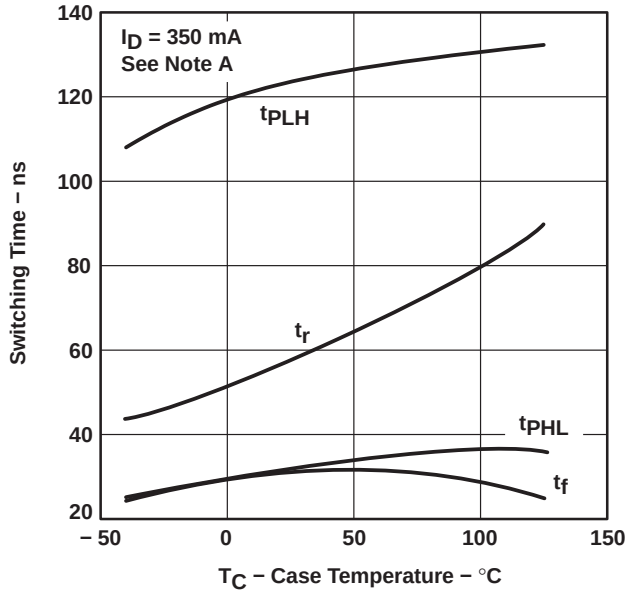


Figure 10

NOTE A: Technique should limit $T_J - T_C$ to 10°C maximum.

TYPICAL CHARACTERISTICS

SWITCHING TIME vs CASE TEMPERATURE

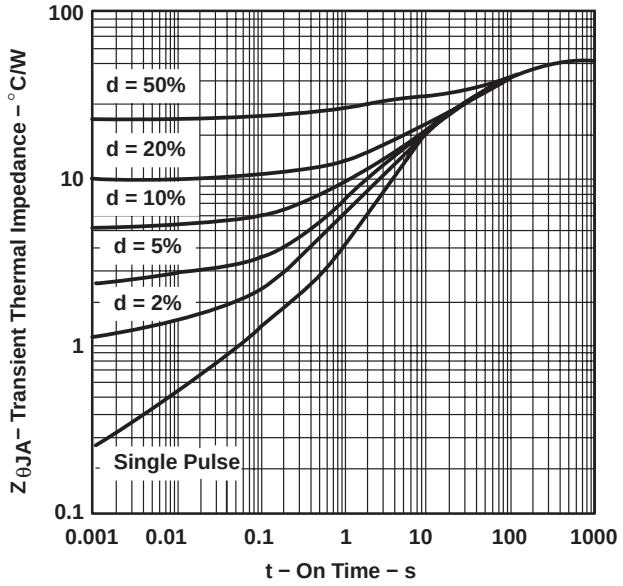


NOTE A: Technique should limit $T_J - T_C$ to 10°C maximum.

Figure 11

THERMAL INFORMATION

NE PACKAGE TRANSIENT THERMAL IMPEDANCE vs ON TIME



The single-pulse curve represents measured data. The curves for various pulse durations are based on the following equation:

$$Z_{\theta JA} = \left|\frac{t_w}{t_c}\right| R_{\theta JA} + \left|1 - \frac{t_w}{t_c}\right| Z_\theta(t_w + t_c) + Z_\theta(t_w) - Z_\theta(t_c)$$

Where:

$Z_\theta(t_w)$ = the single-pulse thermal impedance for t = t_w seconds

$Z_\theta(t_c)$ = the single-pulse thermal impedance for t = t_c seconds

$Z_\theta(t_w + t_c)$ = the single-pulse thermal impedance for t = $t_w + t_c$ seconds

$d = t_w/t_c$

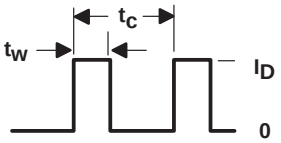


Figure 12

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPIC6A259DW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A259	Samples
TPIC6A259DWG4	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A259	Samples
TPIC6A259DWRG4	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TPIC6A259	Samples
TPIC6A259NE	ACTIVE	PDIP	NE	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-40 to 125	TPIC6A259NE	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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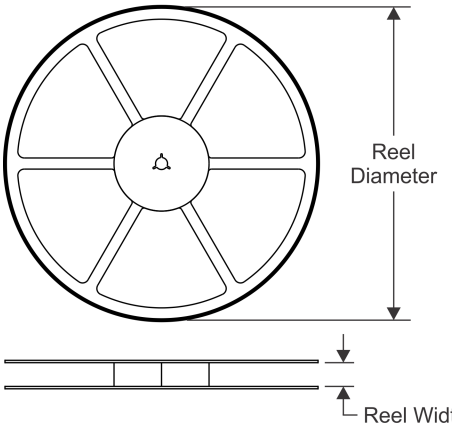
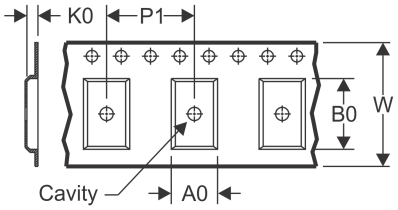
TAPE AND REEL INFORMATION

REEL DIMENSIONS

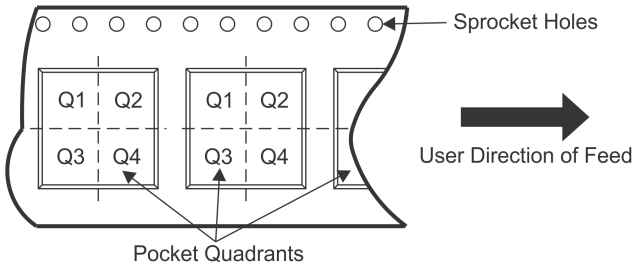


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

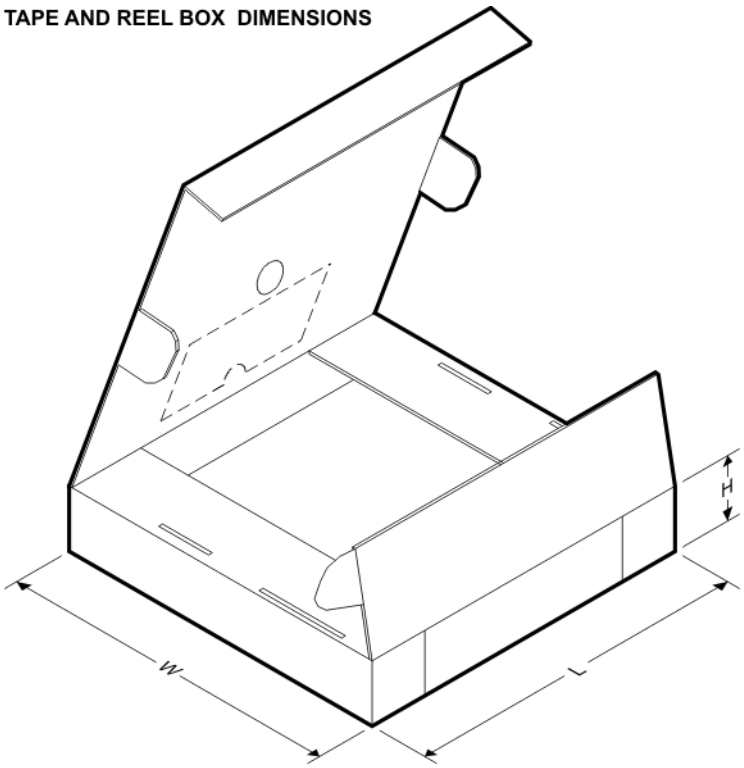
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPIC6A259DWRG4	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1

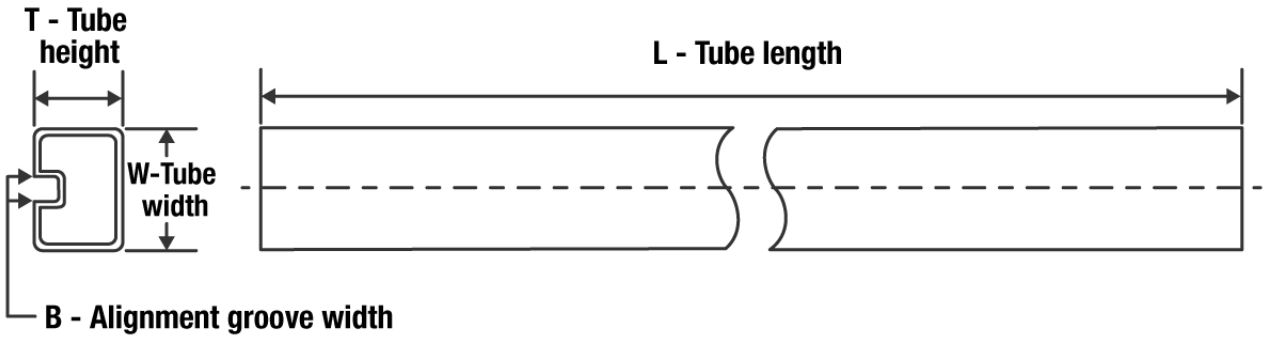
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPIC6A259DWRG4	SOIC	DW	24	2000	350.0	350.0	43.0

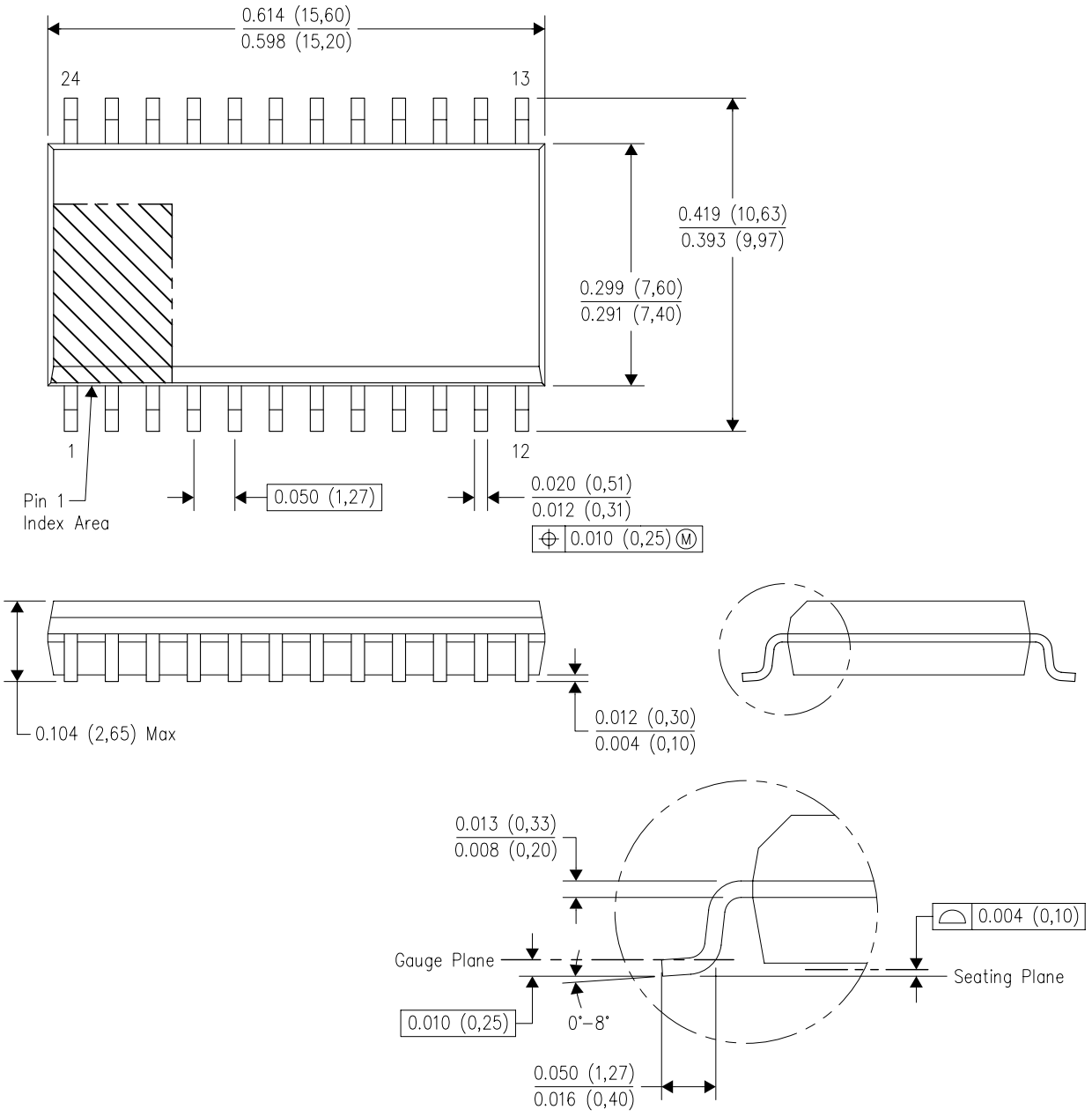
TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
TPIC6A259DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
TPIC6A259DWG4	DW	SOIC	24	25	506.98	12.7	4826	6.6
TPIC6A259NE	NE	PDIP	20	20	506	13.97	11230	4.32

DW (R–PDSO–G24) PLASTIC SMALL OUTLINE



NOTES:
A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
D. Falls within JEDEC MS–013 variation AD.

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